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# Comparison of low dc current traceability methods, and gas capacitors ac-dc dependence

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**Abstract**—The paper compares two instruments for traceable measurement of dc low currents, a custom capacitance-voltage ( $C$ - $V$ ) source and the Ultrastable Low-Current Amplifier (ULCA), a commercial precision transresistance amplifier. The instruments are calibrated through independent traceability routes. The comparison base relative accuracy is in the  $10^{-6} - 10^{-5}$  range. Differences between the two instrument readings, in the  $10^{-5}$  range, are interpreted as an effect of the frequency dependence of the capacitor employed in the  $C$ - $V$  source. Such frequency dependence can affect also primary metrology experiments in other fields.

**Index Terms**—Metrology; Current measurement; Amplifiers, Gain measurement; Calibration; Capacitance.

## I. INTRODUCTION

The traceability of low dc current measurement, in the fA to pA range, is of interest in the fields of single electronics, nanotechnology, ionizing radiation measurements [1], materials science. The generation of traceable dc currents with Ohm's law method is affected by a sizeable uncertainty for currents of 1 nA or below (see [2, Fig. 4], [3, Fig. 6]). Hence, during the past two decades several national metrology institutes developed sources [2], [4]–[13] based on the capacitance-charging ( $C$ - $V$ ) method [14], where a linear voltage ramp  $v(t)$  is applied to a capacitor  $C$ , generating a dc current traceable to voltage and capacitance standards.

More recently, the Physikalisch-Technische Bundesanstalt (PTB) has developed the so-called *Ultrastable-Low noise Current Amplifier* (ULCA) [3], [15]–[18], a precision dc amplifier which gain can be calibrated with a cryogenic current comparator (CCC). The amplifier can work either as a transconductance amplifier, for current measurement, and as a transresistance amplifier, for current generation.

The  $C$ - $V$  method and the ULCA have different advantages and drawbacks, and perform measurements with different traceability sources, as briefly summarized in Tab. I.

In the following we report about a comparison experiment, where currents in the range 10 pA to 1 nA are generated with a  $C$ - $V$  source and measured with an ULCA (and associated instrumentation). This paper is an extension of the proceedings paper [19].

The comparison shows relative deviations between the sourced and measured current values in the order of a few parts in  $10^5$ . The difference is interpreted as a result of the frequency

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dependence of the gas-dielectric capacitors employed in the  $C$ - $V$  source. This effect, which existence and magnitude is still under debate, is of high relevance for several experiments which realise the measurement units of charge, current, mass and force in the revised SI [20].

## II. EXPERIMENTAL

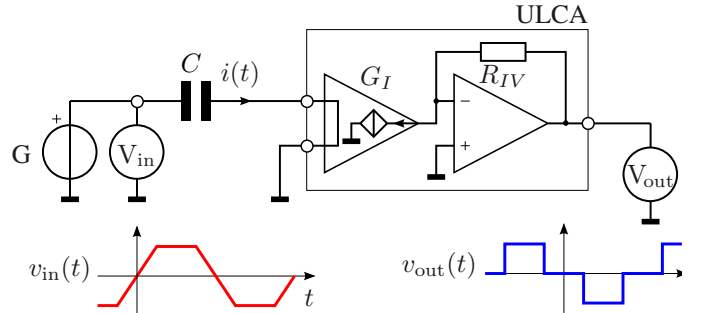


Fig. 1. Principle schematic diagram of the experiment, see Sec. II for an explanation of the symbols. The two stages of the ULCA described in Sec. II-B are shown. The waveform shapes of  $v_{in}(t)$  and  $v_{out}(t)$  are also sketched.

The experiment is outlined in Fig. 1. A more detailed schematic diagram of the instrumentation connections is shown in Fig. 2. The  $C$ - $V$  source, extensively described in [2], [12], [13], is composed of a generator  $G$  providing a piecewise linear voltage ramp  $v_{in}(t) = K_v t$ . The ramp is fed to a capacitor  $C$ , which generates a current  $I = C dv_{in}(t)/dt = C_{dc} K_v$ .

The ULCA  $A$ , having a transresistance gain  $A_{TR}$ , converts the current  $I$  back to a voltage  $v_{out} = A_{TR} I$ . Both the input  $v_{in}(t)$  and the output voltages  $v_{out}(t)$  are sampled at regular time intervals by the voltmeters  $V_{in}$  and  $V_{out}$ , synchronized by

TABLE I  
COMPARISON OF METHODS TO ACHIEVE DC LOW CURRENT TRACEABILITY.

	$C$ - $V$	ULCA
Base accuracy	$> 10^{-5}$	$< 10^{-6}$
Range	fA to $\leq 1$ nA	pA to nA
Traceability	$C, V, t$	$R$ and $I$ ratios
Calibration	cal lab instruments	CCC
Operation	only source	source and meter
Availability	home-made	commercial
Cost	moderate	high

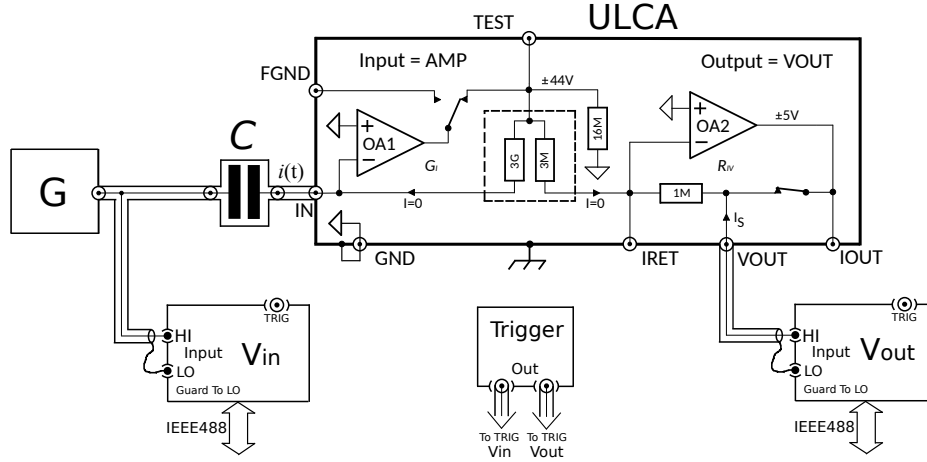


Fig. 2. Schematic diagram of the experiment corresponding to the principle diagram of Fig. 1, showing the ULCA connections. The ULCA simplified schematics is after Ref. [16], where the reader can find a detailed description of its operation and connections.

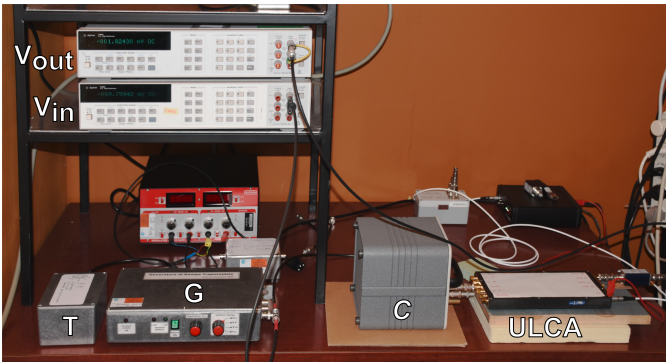


Fig. 3. A photo of the experiment. The main components are labeled as in Fig. 2.

a trigger signal source T. To reduce cable dielectric absorption effects, C and ULCA are connected directly, without using any cable, as shown in Fig. 3.

The samples are acquired through an interface bus (IEEE-488) for off-line processing;  $K_v$  is determined by the samples of  $v_{in}$  numerically.

The actual  $v_{in}(t)$  shape chosen has a symmetric trapezoidal waveform, having a period of  $\approx 800$  s and composed of three different slopes (positive, negative and zero), corresponding to three different calibration current values  $+I$ ,  $-I$  and  $I = \pm 0$ . The current value  $I = 0$  allows to determine instrumental offsets.

Several capacitor models have been employed in the comparison. A list is given in Table II.

#### A. Traceability: C-V source

C is calibrated as a two-terminal pair impedance [22, Sec. 2.2] at the frequency of 1 kHz with an automated capacitance bridge; the measurement is traceable to the Italian national standard of capacitance and ultimately to the quantum Hall effect [23]. The period of T is measured by a frequency meter which is periodically recalibrated.

As will be apparent in Sec. III, the comparison outcome involves only ratios of the measured voltage samples  $v_{in}$  and  $v_{out}$ . Therefore, no traceability to the voltage unit is required. The tracking accuracy of  $v_{in}$  and  $v_{out}$  is calibrated by direct comparison in the 10 V range, and by a precision voltage divider through the different voltage ranges employed.

#### B. Traceability: ULCA

The transresistance amplifier employed is a Magnicon mod. ULCA-1 [15]. The instrument has a highly stable transresistance gain [17] and can be calibrated with a relative uncertainty better than  $10^{-7}$  [16].

The ULCA is composed of two stages in cascade. The input stage is a current-current amplifier, with a nominal gain  $G_I^{nom} = 1000$ , internally realised with active components and a 1000 : 1 resistance ratio ( $3\text{ G}\Omega/3\text{ M}\Omega$ ). The output stage is a transresistance amplifier of nominal gain  $R_{IV}^{nom} = 1\text{ M}\Omega$ . The overall nominal gain of the amplifier is  $A_{TR}^{nom} = G_I^{nom} R_{IV}^{nom} = 1\text{ G}\Omega$ .

Both the input and output stages of ULCA can be calibrated by a CCC with a procedure reported in detail in [15, Sec. V], and the amplifier gain computed as the product of the gain of the two stages,  $A_{TR}^{CCC} = G_I \cdot R_{IV}$ .

The calibration of  $G_I$ , a current ratio, does not involve traceability to SI units. The calibration of  $R_{IV}$  is performed with traceability to the quantum Hall effect. Table III gives a summary of the outcome of the calibrations performed. Data from Table III was used to compute the gain error of Fig. 4. One calibration was performed at PTB and one at INRIM: the main uncertainty contribution is of type A and is different for the two calibrations, since two different CCC models have been employed (a 12-bit commercial Magnicon CCC for the INRIM calibration, a 14-bit CCC [16], [24] for the PTB one).

All values reported have been corrected for temperature, which can be read with a sensor integral with the ULCA. A comparison between the two calibrations shows that the transport and time drift of the ULCA during a period of 1.5 years is of the order of a few parts in  $10^7$ , compatible with previous stability tests [17].

TABLE II  
THE STANDARD CAPACITORS EMPLOYED IN THE  $C$ - $V$  SOURCE.

Label	$C^{\text{nom}}$	Company	Model	Serial	Year	Dielectric	Notes
GR1000	1000 pF	General Radio	1404-A	3144	1976	N <sub>2</sub>	[21] three terminal converted to two-port, trimmer removed
ESI1000	1000 pF	Electro Scientific Industries	SC1000A	223	1982	N <sub>2</sub>	Reconfigured as two-port. Trimmer in place
SUL100	100 pF	H. W. Sullivan	C8002	681103	1982	Air	Reconfigured as two-port. Trimmer removed

TABLE III  
OUTCOME OF THE CALIBRATION OF THE TWO STAGES OF THE ULCA.

$G_I/G_I^{\text{nom}} - 1$	$u_r G_I$	$R_{IV}/R_{IV}^{\text{nom}} - 1$	$u_r(R_{IV})$	Date	Source
$-0.63 \times 10^{-6}$	$2 \times 10^{-8}$	$11.03 \times 10^{-6}$	$2 \times 10^{-8}$	2017.10.26	22486 PTB 17 certificate
$-0.99 \times 10^{-6}$	$3 \times 10^{-7}$	$10.59 \times 10^{-6}$	$1 \times 10^{-7}$	2019.03.05	INRIM calibration

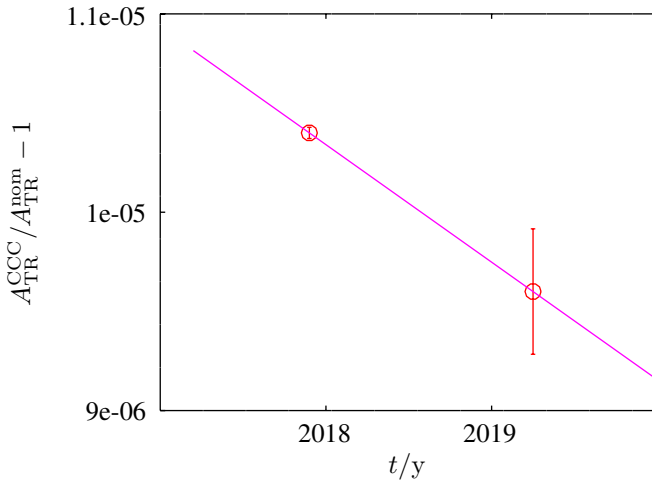


Fig. 4. The gain error  $A_{\text{TR}}^{\text{CCC}}/A_{\text{TR}}^{\text{nom}}$ , where  $A_{\text{TR}}^{\text{CCC}} = G_I \times R_{IV}$ . Data are taken from Table III.

The value  $A_{\text{TR}} = 1.000\,010\,4(3)\text{ G}\Omega$  at the time of the experiment can be computed by interpolation.

### III. RESULTS

Different quantities can be chosen to express the comparison outcome. In the following, we use the gain deviation

$$\delta A_{\text{TR}} = \frac{A_{\text{TR}}^{\text{CV}} - A_{\text{TR}}^{\text{CCC}}}{A_{\text{TR}}^{\text{nom}}}, \quad (1)$$

the difference, normalized to the nominal value  $A_{\text{TR}}^{\text{nom}} = 1\text{ G}\Omega$ , between  $A_{\text{TR}}^{\text{CV}}$  (the ULCA gain calibrated with the  $C$ - $V$  source) and  $A_{\text{TR}}^{\text{CCC}}$ .

$A_{\text{TR}}^{\text{CV}}$  can be expressed [13] as

$$A_{\text{TR}}^{\text{CV}} = \left( C \frac{1}{v_{\text{out}}(t)} \frac{dv_{\text{in}}(t)}{dt} \right)^{-1}; \quad (2)$$

Eq. (2) shows, as anticipated in Sec. II-A, that a traceability to the voltage unit is not required by the comparison.

The results of the comparison are shown in Tab. IV, which reports the measurement outcome  $\delta A_{\text{TR}}$  on the three capaci-

tors of Table II versus different experimental conditions<sup>1</sup>. The same data are plotted in Fig. 5.

An example of uncertainty budget for  $\delta A_{\text{TR}}$  is reported in Tab. V; more details about the expression of the uncertainty of the  $C$ - $V$  source can be found in [2]. The expanded ( $k = 2$ ) uncertainty  $U(\delta A_{\text{TR}})$ , reported in Table IV and Figure 5, is for all measurements dominated by the contributions to  $A_{\text{TR}}^{\text{CV}}$ .

The comparison shows that  $\delta A_{\text{TR}} > 0$  for the capacitors GR1000 and ESI1000, and is compatible with zero for SUL100. An interpretation of such outcome is proposed in the next Section.

## IV. DISCUSSION

### A. Frequency dependence of gas-dielectric capacitors

Capacitance standards are made of metallic electrodes separated by a dielectric medium. Solid- and liquid-dielectrics have a dielectric permittivity  $\epsilon(f)$  dependent on the frequency  $f$  of the electric field. For low-loss dielectrics,  $\epsilon(f)$  has a fractional power law shape, extending down to very low frequencies [25].

Gas dielectrics show a Debye response with relaxation frequencies in the millimetric range or beyond:  $\epsilon(f)$  can be considered constant up to the GHz range [26]. Other mechanisms generating a frequency dependence in the capacitance  $C(f)$  include parasitic inductances (e.g, wiring), giving a  $f^2$  dependence, electromagnetic radiation, or eddy currents in the electrodes (showing a  $f^{\frac{1}{2}}$  dependence) [27]. All these phenomena are also negligible at acoustic frequencies or below.

In addition to  $C$ - $V$  sources, several primary metrology experiments, either purely electrical or electro-mechanical, involve capacitor elements which are conveniently measured at audio frequency but are then energized in the dc regime. Electron-counting capacitance standards (ECCS) realise the coulomb by accumulating individual electrons on a vacuum-gap cryogenic capacitor [28]. Electrostatic balances for the realisation of mass and force units in the low range (mg to ng, mN to nN) [29]–[32] involve the measured gradient  $\partial C/\partial x$  versus the mechanical displacement  $x$ ; setups for the

<sup>1</sup>The actual source voltage slope  $K_v$  is slightly lower,  $-5\%$ , than the nominal one reported in Table IV, and consequently the corresponding current  $I^{\text{nom}}$ . This is to provide some margins to avoid noise clipping and therefore systematic errors when measured quantities are close to the instrumental range. The values have been rounded to decadal ones to facilitate the table reading.



TABLE IV  
RESULTS OF THE COMPARISON.

$C$ label	$C^{\text{nom}}$	$K_v$	$I^{\text{nom}}$	$V_{\text{out}}$	$\delta A_{\text{TR}} \times 10^6$	$U(\delta A_{\text{TR}}) \times 10^6$
GR1000	1000 pF	$0.1 \text{ V s}^{-1}$	100 pA	100 mV	+24.2	7.3
GR1000	1000 pF	$0.1 \text{ V s}^{-1}$	100 pA	100 mV	+26.3	8.3
GR1000	1000 pF	$1 \text{ V s}^{-1}$	1 nA	1 V	+22.2	8.8
ESI1000	1000 pF	$0.1 \text{ V s}^{-1}$	100 pA	100 mV	+39.9	8.3
SUL100	100 pF	$0.1 \text{ V s}^{-1}$	10 pA	10 mV	+6.2	24.2
SUL100	100 pF	$0.1 \text{ V s}^{-1}$	10 pA	10 mV	-9.3	23.4
SUL100	100 pF	$1 \text{ V s}^{-1}$	100 pA	100 mV	+12.7	45.8

TABLE V  
EXAMPLE OF UNCERTAINTY BUDGET FOR  $\delta A_{\text{TR}}$ .

Symbol	$X$	$u_r(X) \times 10^6$	
$C$	1000 pF	2.0	30 %
$K_v$	$0.1 \text{ V s}^{-1}$	0.5	2 %
$V_{\text{out}}$	100 mV	1.2	10 %
$T$	1.048 s	1.0	8 %
noise		2.5	40 %
$A_{\text{TR}}^{\text{CV}}$	1 G $\Omega$	$3.6 \times 10^{-6}$	98 %
$A_{\text{TR}}^{\text{CCC}}$	1 G $\Omega$	$3.1 \times 10^{-7}$	2 %
$\delta A_{\text{TR}}$		$3.6 \times 10^{-6}$	

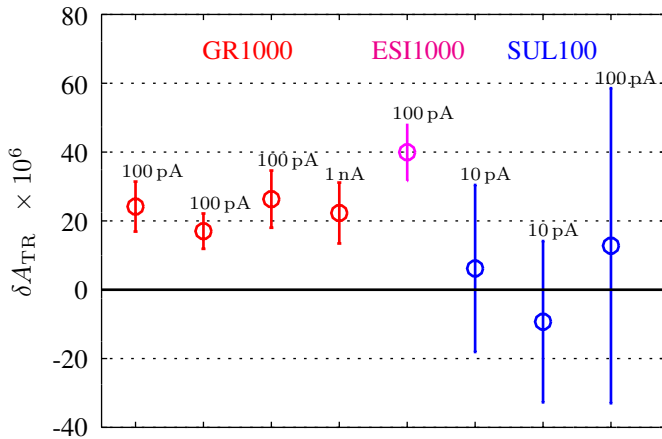


Fig. 5. The data of Table IV, displayed in graphical form.

measurement of the gravitational constant can involve [33], [34] the balancing of the gravitational force by electrostatic actuators. In all these experiments, the limited knowledge of the frequency dependence of the critical capacitive element of the experiment can become a significant uncertainty source.

Frequency dependencies in gas- or vacuum-dielectric capacitors were experimentally observed [35]–[39]. Giblin *et al.* [37] gave some evidence that the dc capacitance  $C(0)$  may be predicted by extrapolation from several measurements performed in the in the audio frequency band.

These dependencies were ascribed to effects of dielectric films, absorbed or chemisorbed on the metallic electrode surfaces; the films act as high-value, lossy solid-dielectric capacitors in series with the gas-dielectric one.

### B. An interpretation of the comparison

The calculation of the results of Tab. IV the possible dependence over frequency of  $C$  was not considered, both for the estimate and for the uncertainty (see also Tab. V).

Both the  $C$ - $V$  source and the ULCA are ultimately traceable to the quantum Hall resistance. Equation 2 shows that the experiment can be reinterpreted as an  $RC$  comparison performed close to dc frequency.

Under this assumption, since  $\delta A_{\text{TR}} \ll 1$ , we can write

$$\delta A_{\text{TR}} = \delta C = \frac{C(0) - C(f)}{C^{\text{nom}}}, \quad (3)$$

where the capacitor being employed, of nominal capacitance  $C^{\text{nom}}$ , has a near-dc capacitance  $C(0)$  determined with the experiment, and a  $C(f)$  capacitance measured during the  $C$ - $V$  source calibration (Sec. II-A).

The data of Table 5 are compatible with the interpretation of a surface-layer effect (Sec. IV-A):

- $\delta C \leq 0$  for all capacitors. This is consistent with other measurements [35]–[39] and an explanation of the effect in terms of surface effects;
- $\delta C$  shows no significant dependence over the maximum applied voltage  $V^{\text{nom}}$ , suggesting a linear dielectric phenomenon;
- $\delta C$  is strictly positive for GR1000 and ESI1000, both having  $C^{\text{nom}} = 1000 \text{ pF}$ , and compatible with zero for SUL100, having  $C^{\text{nom}} = 100 \text{ pF}$ . The physical construction of the three capacitors is similar, but SUL100 has a much larger electrode spacing than GR1000 or ESI1000. A surface layer effect and the corresponding  $\delta C$  would therefore be much smaller for SUL100.

## V. CONCLUSIONS

The  $C$ - $V$  source and the ULCA both provide low-current traceability to low dc currents, and are to some extent complementary: the  $C$ - $V$  source can easily operate also in the fA range, the ULCA has a fixed gain but provides ultimate accuracy. The comparison, performed in a current range (10 pA to 1 nA) suitable for both instruments, shows a compatibility in the  $10^{-5}$  range, well beyond the specifications of other commercial low-current instrumentation.

The comparison outcome has been interpreted in terms of the residual frequency dependence of the gas-dielectric capacitors employed in the  $C$ - $V$  source, which can be due to surface layer effects. This frequency dependence can be a

source of error also in electrostatic actuators employed in other primary metrology experiments, such as electrostatic balances for the realisation of SI mass and force units, and for the measurement of the gravitational constant.

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